


<b>Search Notes</b> 	<b>Application/Control No.</b> 10566667	<b>Applicant(s)/Patent Under Reexamination</b> SEKIGUCHI, YUSHI
	<b>Examiner</b> Tsz K Chiu	<b>Art Unit</b> 2822

SEARCHED			
Class	Subclass	Date	Examiner
257	440, 461	11/22/08	TC
257	184,258,440,E27.134,E31.054	4/26/09	TC

SEARCH NOTES		
Search Notes	Date	Examiner
updated search	4/26/09	TC
Discussed with Primary examiner Mary Wilczewski	4/23/09	TC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	184	4/26/09	TC

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